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Český institut pro akreditaci, o.p.s.
(Czech Accreditation Institute)
Hájkova 2747/22, Žižkov, 130 00 Praha 3

issues

according to section 16 of Act No. 22/1997 Coll., on technical requirements for products and on changes and amendments to some Acts, as amended

CERTIFICATE OF ACCREDITATION

No. 445/2025

SEC electronic s.r.o.
with registered office Dražkovice 155, 533 33 Pardubice
Company Registration No. 28774213

for the Calibration Laboratory No. 2356
Calibration Laboratory

Scope of accreditation:

Calibration in the fields of temperature, electrical quantities, time and frequency to the extent as specified in the appendix to this Certificate.

This Certificate of Accreditation is a proof of accreditation issued on the basis of assessment of fulfillment of the accreditation criteria in accordance with

ČSN EN ISO/IEC 17025:2018

In its activities performed within the scope and for the period of validity of this Certificate, the abovementioned Accredited Body is entitled to refer to this Certificate, provided that the accreditation is not suspended and the Accredited Body meets the specified accreditation requirements in accordance with the relevant regulations applicable to the activity of an accredited conformity assessment body.

This Certificate of Accreditation replaces, to the full extent, Certificate No.: 598/2022 of 07/12/2022, and/or any administrative acts building upon it.

The Certificate of Accreditation is valid until: 07/12/2027

Prague: 03/09/2025



Signed in the Czech original:
Jan Velíšek on 03/09/2025

Jan Velíšek
Director of the Department
of Testing and Calibration Laboratories
Czech Accreditation Institute

This translation of the Czech original has been issued by: Eliška Frycová

Accredited entity according to ČSN EN ISO/IEC 17025:2018:

SEC electronic s.r.o.
CAB number 2356, Calibration Laboratory
Arnošta z Pardubic 2762, 530 02 Pardubice

CMC for the field of measured quantity: Temperature

Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
1	Resistance thermometers without RTD	Pt 100-385	-200 °C	to	-130 °C		0.050 °C	Direct generation with a standard resistor	SEC-KM-°C	
			-130 °C	to	-100 °C		0.065 °C			
			-100 °C	to	0 °C		0.075 °C			
			0 °C	to	100 °C		0.090 °C			
			100 °C	to	300 °C		0.13 °C			
			300 °C	to	400 °C		0.14 °C			
			400 °C	to	500 °C		0.17 °C			
			500 °C	to	700 °C		0.21 °C			
			700 °C	to	850 °C		0.24 °C			
		Pt 100-3916	-100 °C	to	0 °C		0.070 °C			
			0 °C	to	100 °C		0.090 °C			
			100 °C	to	200 °C		0.11 °C			
			200 °C	to	450 °C		0.16 °C			
		Pt 100-3920	-200 °C	to	-80 °C		0.050 °C			
			-80 °C	to	0 °C		0.070 °C			
			0 °C	to	100 °C		0.085 °C			
			100 °C	to	200 °C		0.11 °C			
			200 °C	to	400 °C		0.14 °C			
			400 °C	to	600 °C		0.19 °C			
		Pt 500	-200 °C	to	-130 °C		0.040 °C			
			-130 °C	to	-100 °C		0.045 °C			
			-100 °C	to	0 °C		0.060 °C			
			0 °C	to	100 °C		0.080 °C			
			100 °C	to	300 °C		0.10 °C			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		300 °C	to	400 °C			0.12 °C			
		400 °C	to	500 °C			0.14 °C			
		500 °C	to	700 °C			0.18 °C			
		700 °C	to	850 °C			0.22 °C			
		Pt 1000								
		-200 °C	to	-150 °C			0.040 °C			
		-150 °C	to	-100 °C			0.050 °C			
		-100 °C	to	0 °C			0.055 °C			
		0 °C	to	100 °C			0.070 °C			
		100 °C	to	300 °C			0.10 °C			
		300 °C	to	400 °C			0.12 °C			
		400 °C	to	500 °C			0.14 °C			
		500 °C	to	700 °C			0.18 °C			
		700 °C	to	850 °C			0.21 °C			
		Cu 10								
		-200 °C	to	-30 °C			0.40 °C			
		-30 °C	to	100 °C			0.45 °C			
		100 °C	to	260 °C			0.47 °C			
		Ni 120								
		-80 °C	to	10 °C			0.055 °C			
		10 °C	to	260 °C			0.060 °C			
		Ni 1000								
		-50 °C	to	70 °C			0.050 °C			
		70 °C	to	200 °C			0.055 °C			
2	Sensing part of resistance thermometers							Direct measurement by a standard multimeter	SEC-KM-°C	
	Pt 100-385	-200 °C	to	-80 °C			0.032 °C			
		-80 °C	to	100 °C			0.075 °C			
		100 °C	to	400 °C			0.080 °C			
		400 °C	to	700 °C			0.090 °C			
		700 °C	to	850 °C			0.10 °C			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
	Pt 100-3916	-100 °C	to	-70 °C			0.032 °C	Direct generation and measurement with a standard calibrator and multimeter – without cold junction ⁴ compensation	SEC-KM-°C	
		-70 °C	to	10 °C			0.070 °C			
		10 °C	to	200 °C			0.075 °C			
		200 °C	to	450 °C			0.082 °C			
	Pt 100-3920	-200 °C	to	-70 °C			0.030 °C			
		-70 °C	to	100 °C			0.072 °C			
		100 °C	to	400 °C			0.080 °C			
		400 °C	to	600 °C			0.090 °C			
	Pt 500	-200 °C	to	100 °C			0.038 °C			
		100 °C	to	400 °C			0.12 °C			
		400 °C	to	850 °C			0.15 °C			
	Pt 1000	-200 °C	to	-50 °C			0.035 °C			
		-50 °C	to	500 °C			0.070 °C			
		500 °C	to	850 °C			0.080 °C			
	Cu 10, Ni 120	-200 °C	to	260 °C			0.32 °C			
		-80 °C	to	-30 °C			0.040 °C			
		-30 °C	to	10 °C			0.055 °C			
		10 °C	to	260 °C			0.050 °C			
	Ni 1000	-50 °C	to	-20 °C			0.035 °C			
		-20 °C	to	70 °C			0.050 °C			
		70 °C	to	200 °C			0.045 °C			
3	Thermocouple temperature sensors							Direct generation and measurement with a standard calibrator and multimeter – without cold junction ⁴ compensation	SEC-KM-°C	
	type “R”	-40 °C	to	-30 °C			1.8 °C			
		-30 °C	to	20 °C			1.5 °C			
		20 °C	to	90 °C			1.1 °C			
		90 °C	to	300 °C			0.90 °C			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		300 °C	to	500 °C			0.72 °C			
		500 °C	to	600 °C			0.65 °C			
		600 °C	to	1,700 °C			0.60 °C			
		type "S"								
		-40 °C	to	0 °C			1.5 °C			
		0 °C	to	100 °C			1.1 °C			
		100 °C	to	500 °C			0.80 °C			
		500 °C	to	1,700 °C			0.65 °C			
		type "D"								
		0 °C	to	50 °C			0.72 °C			
		50 °C	to	100 °C			0.56 °C			
		100 °C	to	1,000 °C			0.40 °C			
		1,000 °C	to	2,400 °C			0.90 °C			
		type "U"								
		-190 °C	to	-90 °C			0.37 °C			
		-90 °C	to	-20 °C			0.26 °C			
		-20 °C	to	0 °C			0.21 °C			
		0 °C	to	600 °C			0.17 °C			
		type "L"								
		-190 °C	to	-110 °C			0.26 °C			
		-100 °C	to	-20 °C			0.21 °C			
		-20 °C	to	600 °C			0.17 °C			
		600 °C	to	900 °C			0.14 °C			
		type "N"								
		-250 °C	to	-200 °C			2.4 °C			
		-200 °C	to	-130 °C			0.72 °C			
		-130 °C	to	-100 °C			0.35 °C			
		-100 °C	to	50 °C			0.30 °C			
		50 °C	to	200 °C			0.26 °C			
		200 °C	to	1,300 °C			0.22 °C			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
	type "C"	0 °C	to	50 °C			0.56 °C			
		50 °C	to	100 °C			0.49 °C			
		100 °C	to	200 °C			0.43 °C			
		200 °C	to	1,200 °C			0.41 °C			
		1,200 °C	to	1,400 °C			0.46 °C			
		1,400 °C	to	1,600 °C			0.52 °C			
		1,600 °C	to	1,800 °C			0.56 °C			
		1,800 °C	to	2,000 °C			0.60 °C			
		2,000 °C	to	2,300 °C			0.80 °C			
	type "B"	100 °C	to	150 °C			7.1 °C			
		150 °C	to	200 °C			3.6 °C			
		200 °C	to	300 °C			2.4 °C			
		300 °C	to	500 °C			1.5 °C			
		500 °C	to	800 °C			0.90 °C			
		800 °C	to	1,000 °C			0.80 °C			
		1,000 °C	to	1,400 °C			0.65 °C			
		1,400 °C	to	1,800 °C			0.60 °C			
	type "E"	-250 °C	to	-220 °C			0.72 °C			
		-220 °C	to	-205 °C			0.39 °C			
		-205 °C	to	-200 °C			0.29 °C			
		-200 °C	to	-100 °C			0.19 °C			
		-100 °C	to	50 °C			0.17 °C			
		50 °C	to	1,000 °C			0.14 °C			
	type "T"	-250 °C	to	-220 °C			1.1 °C			
		-220 °C	to	-205 °C			0.56 °C			
		-205 °C	to	-200 °C			0.46 °C			
		-200 °C	to	-100 °C			0.27 °C			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
	type "K"	-100 °C	to	0 °C			0.23 °C			
		0 °C	to	200 °C			0.19 °C			
		200 °C	to	400 °C			0.16 °C			
		-260 °C	to	-245 °C			2.4 °C			
		-245 °C	to	-205 °C			1.1 °C			
		-205 °C	to	-150 °C			0.46 °C			
		-150 °C	to	-10 °C			0.26 °C			
		-10 °C	to	1,350 °C			0.23 °C			
		-200 °C	to	-155 °C			0.34 °C			
		-155 °C	to	-110 °C			0.24 °C			
	type "J"	-110 °C	to	-5 °C			0.20 °C			
		-5 °C	to	1,150 °C			0.17 °C			

¹ Asterisk at the ordinal number identifies the calibrations, which the Laboratory is qualified to carry out outside the permanent laboratory premises.

² The expanded measurement uncertainty is in accordance with ILAC-P14 and EA-4/02 M part of CMC, and it is the lowest value of the respective uncertainty. If not stated otherwise, its coverage probability is approx. 95 %. If not stated otherwise, the uncertainty values stated without a unit are relative to the value measured. The uncertainty value stated herein is based on the best conditions achievable by the laboratory; the uncertainty value of a specific calibration may be higher, depending on the conditions of such a calibration. For identical extreme values of adjacent ranges, the lower uncertainty value always applies.

³ If the document identifying the calibration procedure is dated, only these specific procedures are used. If the document identifying the calibration procedure is not dated, the latest edition of the specified procedure is used (including any changes).

⁴ When calibrating cold-point compensated thermocouples, the effect of the compensation line and the cold-point uncertainty must be taken into account.

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CMC for the field of measured quantity: Electrical quantities

Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Location
		min.	unit	max.	unit					
1*	DC voltage / Power supplies, high voltage test sources (up to 50 kV), calibrators, instruments for certified electricians			1 mV			0.2 µV	Direct measurement by a standard multimeter	SEC-KM-UDC	
				10 mV			0.4 µV			
				100 mV			1.5 µV			
				1 V			0.0012 %			
				10 V			0.0010 %			
				100 V			0.0015 %			
				1,000 V			0.0017 %			
		0 mV	to	200 mV			2.5 µV			
		200 mV	to	2 V			0.0015 %			
		2 V	to	20 V			0.0015 %			
		20 V	to	200 V			0.0015 %			
		200 V	to	1,100 V			0.0020 %			
		1.1 kV	to	5 kV			1,0 %	Direct measurement by a standard voltmeter with a HV divider		
		5 kV	to	10 kV			0,9 %			
		10 kV	to	50 kV			1,5 %			
	DC voltage / Analogue and digital voltmeters, multimeters, tong-test meters, oscilloscopes			100 µV			2.7 µV	Comparison with a standard calibrator		
				1 mV			2.7 µV			
				10 mV			3 µV			
				100 mV			0.0030 %			
				1 V			0.0020 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		10 V					0.0020 %			
		100 V					0.0020 %			
1,000 V				0.0025 %						
0 mV	to	200 mV		6 μV						
200 mV	to	2 V		0.0040 %						
2 V	to	20 V		0.0040 %						
20 V	to	200 V		0.0040 %						
200 V	to	1,100 V		0.0050 %						
		1100 V to 6000 V					1.5 %	Comparison with a standard multimeter with a resistance divider		
2*	Direct-current / Power-supplies, calibrators, instruments for certified electricians	10 μA					0.007 μA	Direct measurement by a standard multimeter	SEC-KM-IDC	
		100 μA					0.007 μA			
		1 mA					0.07 μA			
		10 mA					0.7 μA			
		100 mA					14 μA			
		1 A					210 μA			
		1.9 A					0.4 mA			
		10 A					0.010 %			
		20 A					0.030 %			
		100 A					0.050 %			
		0 μA	to	20 μA	0.050 % + 3.4 nA					
		20 μA	to	200 μA	0.010 %					
		200 μA	to	2 mA	0.010 %					
		2 mA	to	20 mA	0.010 %					
		20 mA	to	200 mA	0.015 %					

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		200 mA	to	2 A		0.025 %	Direct measurement by a standard multimeter with a shunt			
		2 A	to	10 A		0.020 %				
		10 A	to	20 A		0.040 %				
		20 A	to	100 A		0.10 %				
	Direct-current / Analogue and digital ammeters, multimeters, tong- test meters							Direct generation by a standard calibrator		
					10 µA		0.014 µA			
					100 µA		0.014 µA			
					1 mA		0.015 µA			
					10 mA		1.4 µA			
					100 mA		14 µA			
					1 A		0.28 mA			
					10 A		0.042 %			
					20 A		0.042 %			
					30 A		0.10 %			
					90 A		0.20 %			
		0 µA	to	10 µA		0.050 % + 3.4 nA				
		10 µA	to	200 µA		0.015 %				
		200 µA	to	2 mA		0.015 %				
		2 mA	to	20 mA		0,025 %				
		20 mA	to	200 mA		0.015 %				
		200 mA	to	2 A		0.030 %				
		2 A	to	20 A		0.080 %	Comparison with a standard multimeter with a shunt			
		20 A	to	90 A		0.20 %				

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		min.	unit	max.	unit					
		90 A	to	200 A			0.30 %	Comparison with a clamp probe with a multimeter		
		200 A	to	1.9 kA			0.40 %			
3*	AC voltage / Power supplies, high voltage test sources (up to 50 kV), calibrators, instruments for certified electricians							Direct measurement by a standard multimeter	SEC-KM-UAC	
				1 mV		10 Hz to 40 Hz 40 Hz to 10 kHz 10 kHz to 30 kHz 30 kHz to 100 kHz	10 µV 6 µV 15 µV 30 µV			
				10 mV		10 Hz to 40 Hz 40 Hz to 10 kHz 10 kHz to 30 kHz 30 kHz to 100 kHz	10 µV 8 µV 15 µV 20 µV			
				100 mV		10 Hz to 40 Hz 40 Hz to 10 kHz 10 kHz to 30 kHz 30 kHz to 100 kHz	0.025 % 0.020 % 0.050 % 0.14 %			
				1 V		10 Hz to 40 Hz 40 Hz to 10 kHz 10 kHz to 30 kHz 30 kHz to 100 kHz 100 kHz to 300 kHz 300 kHz to 1 MHz	0.018 % 0.015 % 0.030 % 0.085 % 0.58 % 3.5 %			
				10 V		10 Hz to 40 Hz 40 Hz to 10 kHz 10 kHz to 30 kHz 30 kHz to 100 kHz	0.018 % 0.015 % 0.030 % 0.085 %			

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		min.	unit	max.	unit					
						100 kHz to 300 kHz	0.58 %			
						300 kHz to 1 MHz	3.5 %			
		100 V				10 Hz to 40 Hz	0.018 %			
						40 Hz to 10 kHz	0.015 %			
						10 kHz to 30 kHz	0.030 %			
						30 kHz to 100 kHz	0.085 %			
						100 kHz to 300 kHz	0.60 %			
		1,000 V				10 Hz to 40 Hz	0.034 %			
						40 Hz to 10 kHz	0.020 %			
						10 kHz to 30 kHz	0.030 %			
						30 kHz to 100 kHz	0.080 %			
		1 mV	to	10 mV		10 Hz to 40 Hz	10 µV			
						40 Hz to 10 kHz	10 µV			
						10 kHz to 30 kHz	15 µV			
						30 kHz to 100 kHz	30 µV			
		10 mV	to	100 mV		10 Hz to 40 Hz	0.062 %			
						40 Hz to 10 kHz	0.040 %			
						10 kHz to 30 kHz	0.11 %			
						30 kHz to 100 kHz	0.28 %			
		100 mV	to	200 mV		10 Hz to 40 Hz	0.025 %			
						40 Hz to 10 kHz	0.020 %			
						10 kHz to 30 kHz	0.05 %			
						30 kHz to 100 kHz	0.25 %			
						100 kHz to 300 kHz	0.6 %			
						300 kHz to 1 MHz	3.5 %			
		200 mV	to	20 V		10 Hz to 40 Hz	0.025 %			
						40 Hz to 10 kHz	0.020 %			

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		min.	unit	max.	unit					
						10 kHz to 30 kHz	0.050 %			
						30 kHz to 100 kHz	0.17 %			
						100 kHz to 300 kHz	0.6 %			
						300 kHz to 1 MHz	3.5 %			
		20 V	to	200 V		10 Hz to 40 Hz	0.025 %			
						40 Hz to 10 kHz	0.020 %			
						10 kHz to 30 kHz	0.050 %			
						30 kHz to 100 kHz	0.10 %			
						100 kHz to 300 kHz	0.60 %			
		200 V	to	1,100 V		10 Hz to 40 Hz	0.068 %			
						40 Hz to 10 kHz	0.060 %			
						10 kHz to 30 kHz	0.090 %			
					30 kHz to 100 kHz	0.19 %				
							Direct measurement with a standard multimeter with a HV divider			
1.1 kV	to	50 kV		50 Hz	1.5 %					
AC voltage / Analogue and digital voltmeters, multimeters, tong-test meters, oscilloscopes		1 mV				10 Hz to 30 Hz	13 μV	Direct generation by a standard calibrator		
						30 Hz to 30 kHz	13 μV			
						30 kHz to 100 kHz	13 μV			
						100 kHz to 300 kHz	2.7 %			
						300 kHz to 1 MHz	4.7 %			
		10 mV				10 Hz to 30 Hz	18 μV			
						30 Hz to 30 kHz	17 μV			
						30 kHz to 100 kHz	22 μV			
						100 kHz to 300 kHz	0.53 %			
						300 kHz to 1 MHz	1.6 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		100 mV				10 Hz to 30 Hz	0.070 %			
						30 Hz to 30 kHz	0.060 %			
						30 kHz to 100 kHz	0.12 %			
						100 kHz to 300 kHz	0.32 %			
						300 kHz to 1 MHz	1.2 %			
		1 V				10 Hz to 30 Hz	0.047 %			
						30 Hz to 30 kHz	0.030 %			
						30 kHz to 100 kHz	0.045 %			
						100 kHz to 300 kHz	0.17 %			
						300 kHz to 1 MHz	0.93 %			
		10 V				10 Hz to 30 Hz	0.047 %			
						30 Hz to 30 kHz	0.030 %			
						30 kHz to 100 kHz	0.045 %			
						100 kHz to 300 kHz	0.17 %			
						300 kHz to 1 MHz	0.93 %			
		100 V				10 Hz to 30 Hz	0.047 %			
						30 Hz to 30 kHz	0.030 %			
						30 kHz to 100 kHz	0.047 %			
		1,000 V				45 Hz to 33 Hz	0.059 %			
		1 mV	to	10 mV		10 Hz to 30 Hz	36 µV			
						30 Hz to 30 kHz	34 µV			
						30 kHz to 100 kHz	44 µV			
						100 kHz to 300 kHz	5.0 %			
						300 kHz to 1 MHz	8.0 %			
		10 mV	to	200 mV		10 Hz to 30 Hz	0.14 %			
						30 Hz to 30 kHz	0.12 %			
						30 kHz to 100 kHz	0.24 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion		
		min.	unit	max.	unit							
						100 kHz to 300 kHz 300 kHz to 1 MHz	1.0 % 3.2 %					
		200 mV	to	20 V		10 Hz to 30 Hz 30 Hz to 30 kHz 30 kHz to 100 kHz 100 kHz to 300 kHz 300 kHz to 1 MHz	0.090 % 0.060 % 0.090 % 0.70 % 2.0 %					
		20 V	to	200 V		10 Hz to 30 Hz 30 Hz to 30 kHz 30 kHz to 100 kHz	0.090 % 0.060 % 0.090 %					
		200 V	to	1,000 V		45 Hz to 30 kHz	0.11 %					
		1,000 V	to	5,000 V		50 Hz to 60 Hz	1.5 %					
4*	Alternating-current / Power- supplies, calibrators, instruments for certified electricians					10 Hz to 5 kHz	0.26 % 0.050 % 0.050 % 0.050 % 0.050 % 0.10 %	Direct measurement by a standard multimeter	SEC-KM-IAC			
							10 Hz to 1 kHz				0.070 % 0.070 % 0.075 %	Direct measurement with a standard multimeter with a shunt
		10 µA	to	200 µA	10 Hz to 1 kHz		0.26 %				Direct measurement by a standard multimeter	
		200 µA	to	200 mA			0.05 %					

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion		
		min.	unit	max.	unit							
		200 mA	to	2 A			0.10 %	Direct measurement with a standard multimeter with a shunt				
		200 mA	to	2 A		1 kHz to 5 kHz	0.20 %					
		2 A	to	50 A		10 Hz to 1 kHz	0.20 %					
		50 A	to	150 A		50 Hz	0.30 %					
			150 A	to	1.4 kA		0.40 %	Direct measurement with a current probe with a multimeter				
	Alternating-current / Analogue and digital ammeters, multimeters, tong- test meters, instruments for certified electricians				10 µA		10 Hz to 1 kHz	0.35 %	Direct generation by a standard calibrator		SEC-KM-IAC	
					100 µA			0.083 %				
					1 mA			0.066 %				
					10 mA			0.065 %				
					100 mA			0.065 %				
					1 A			0.085 %				
					10 A		10 Hz to 1 kHz	0.20 %				Comparison with a standard multimeter with a shunt
					20 A			0.20 %				
					30 A		15 Hz to 1 kHz	0.20 %				
					10 µA	to	200 µA					10 Hz to 1 kHz
				200 µA	to	200 mA			0.10 %			
				200 mA	to	2 A			0.12 %			
				2 A	to	20 A		15 Hz to 1 kHz	0.40 %		Comparison with a standard multimeter with a shunt	
				20 A	to	30 A			0.40 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion	
		min.	unit	max.	unit						
		30 A	to	90 A			0.50 %				
		90 A	to	1.0 kA	50 Hz to 100 Hz		0.70 %	Comparison with a standard clamp multimeter			
5*	DC resistance / Resistance boxes, DC resistance dividers, reference DC resistors, instruments for certified electricians								Comparison with a resistance standard	SEC-KM-R	
		100 μΩ						0.058 %			
		1 mΩ						0.0060 %			
		10 mΩ						0.0060 %			
		100 mΩ						0.0060 %			
		1 Ω						0.0025 %			
		10 Ω						0.0025 %			
		100 Ω						0.0025 %			
		1 kΩ						0.0025 %			
		10 kΩ						0.0025 %			
		100 kΩ						0.0025 %			
		1 MΩ						0.0030 %			
10 MΩ						0.0080 %					
100 MΩ						0.012 %					
1 GΩ						0.040 %					
		0 mΩ	to	1 mΩ			2.0 % +2 μΩ	Direct measurement with a microohmmeter			
		1 mΩ	to	100 mΩ			0.50 %				
		100 mΩ	to	1 Ω			0.10 %	Direct measurement with a standard multimeter			
		1 Ω	to	10 Ω			0.010 %				
		10 Ω	to	100 Ω			0.0070 %				
		100 Ω	to	1 kΩ			0.0050 %				

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		1 kΩ	to	10 kΩ			0.0040 %			
		10 kΩ	to	100 kΩ			0.0050 %			
		100 kΩ	to	1 MΩ			0.0090 %			
		1 MΩ	to	10 MΩ			0.018 %			
		10 MΩ	to	100 MΩ			0.090 %			
		100 MΩ	to	1 GΩ			0.50 %			
	DC resistance / Ohmmeters, resistance bridges			100 μΩ			0.0040 %	Direct measurement of reference resistors	SEC-KM-R	
				1 mΩ			0.0020 %			
				10 mΩ			0.0010 %			
				100 mΩ			0.0010 %			
				1 Ω			0.0010 %			
				10 Ω			0.0010 %			
				100 Ω			0.0020 %			
				1 kΩ			0.0020 %			
				10 kΩ			0.0015 %			
				100 kΩ			0.0020 %			
				1 MΩ			0.0020 %			
				10 MΩ			0.0080 %			
				100 MΩ			0.011 %			
				1 GΩ			0.040 %			
		0 mΩ	to	1 Ω			0.2 % + 0.4 mΩ			
		1 Ω	to	10 Ω			0.020 %			
		10 Ω	to	100 Ω			0.020 %			
		100 Ω	to	1 kΩ			0.015 %			
		1 kΩ	to	10 kΩ			0.015 %			
		10 kΩ	to	100 kΩ			0.015 %			
		100 kΩ	to	1 MΩ			0.020 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		1 MΩ	to	10 MΩ			0.040 %			
		10 MΩ	to	100 MΩ			0.10 %			
		100 MΩ	to	1 GΩ			0.50 %			
		1 GΩ	to	10 GΩ			1.0 %			
		10 GΩ	to	50 GΩ			2.5 %			
6	AC resistance / RLC bridges, multimeters			0.1 Ω		100 Hz 1 kHz 10 kHz	0.20 % 0.20 % 1.0 %	Direct generation using a standard RLC calibrator	SEC-KM-RLC	
				1 Ω		100 Hz 1 kHz 10 Hz	0.14 % 0.10 % 0.10 %			
				10 Ω		100 Hz 1 kHz 10 kHz	0.050 % 0.050 % 0.050 %			
				100 Ω		100 Hz 1 kHz 10 kHz	0.020 % 0.020 % 0.020 %			
				1 kΩ		100 Hz 1 kHz 10 kHz	0.020 % 0.020 % 0.020 %			
				10 kΩ		100 Hz 1 kHz 10 kHz	0.020 % 0.020 % 0.020 %			
				100 kΩ		100 Hz 1 kHz 10 kHz	0.020 % 0.020 % 0.020 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
				1 MΩ		100 Hz 1 kHz 10 kHz	0.030 % 0.030 % 0.060 %			
				10 MΩ		100 Hz 1 kHz 10 kHz	0.050 % 0.050 % 0.47 %			
7	Capacity / RLC bridges, multimeters			10 pF		100 Hz 1 kHz 10 kHz	0.86 % 0.50 % 0.50 %	Direct generation using a standard RLC calibrator	SEC-KM-RLC	
				100 pF		100 Hz 1 kHz 10 kHz	0.30 % 0.10 % 0.050 %			
				1 nF		100 Hz 1 kHz 10 kHz	0.050 % 0.050 % 0.050 %			
				10 nF		100 Hz 1 kHz 10 kHz	0.050 % 0.050 % 0.050 %			
				100 nF		100 Hz 1 kHz 10 kHz	0.10 % 0.050 % 0.050 %			
				1 μF		100 Hz 1 kHz 10 kHz	0.050 % 0.050 % 0.050 %			
				10 μF		100 Hz 1 kHz 10 kHz	0.050 % 0.050 % 0.20 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion	
		min.	unit	max.	unit						
		100 μF				100 Hz 1 kHz 10 kHz	0.10 % 0.13 % 0.51 %				
8	Inductance / RLC bridges, multimeters	10 μH				1 kHz 10 kHz	0.58 % 0.32 %	Direct generation using a standard RLC calibrator	SEC-KM-RLC		
		100 μH				100 Hz 1 kHz 10 kHz	0.53 % 0.22 % 0.21 %				
		1 mH				100 Hz 1 kHz 10 kHz	0.22 % 0.11 % 0.11 %				
		10 mH				100 Hz 1 kHz 10 kHz	0.11 % 0.10 % 0.10 %				
		100 mH				100 Hz 1 kHz 10 kHz	0.10 % 0.10 % 0.10 %				
		1 H				100 Hz 1 kHz	0.10 % 0.10 %				
		10 H				100 Hz 1 kHz	0.10 % 0.10 %				
		10 μH				100 kHz	0.30 %				Direct measurement of an inductance standard
		100 μH				100 kHz	0.30 %				
		1,000 μH				100 kHz	0.30 %				

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Location
		min.	unit	max.	unit					
9	DC power / Analogue and digital wattmeters, tong-test meters, instruments for certified electricians (1 V to 1,000 V; 1 mA to 20 A)	1 mVA		to	20 kVA		0.050 %	Direct generation with a standard power calibrator	SEC-KM-P	
	DC power / Calibrators	1 mVA		to	20 kVA		0.10 %	Comparison with a standard power calibrator		
10*	AC power / Analogue and digital wattmeters, varimeters, tong-test meters (40 Hz to 70 Hz, 1 V to 600 V)	0.01 W		to	54 kW	cos φ		Direct generation with a standard power calibrator	SEC-KM-P	
						1	current 10 mA to 10 A 10 A to 90 A			
							0.070 % 0.10 %			
						0.9 to 1	10 mA to 10 A 10 A to 90 A			
							0.081 % 0.1 %			
						0.8 to 0.9	10 mA to 10 A 10 A to 90 A			
							0.075 % 0.13 %			
						0.7 to 0.8	10 mA to 10 A 10 A to 90 A			
							0.070 % 0.15 %			
						0.6 to 0.7	10 mA to 10 A 10 A to 90 A			
							0.090 % 0.17 %			
						0.5 to 0.6	10 mA to 10 A 10 A to 90 A			
							0.090 % 0.19 %			
						0.4 to 0.5	10 mA to 10 A 10 A to 90 A			
							0.10 % 0.22 %			
						0.3 to 0.4	10 mA to 10 A 10 A to 90 A			
							0.15 % 0.35 %			
						0.2 to 0.3	10 mA to 10 A 10 A to 90 A			
							0.19 % 0.39 %			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
						0.1 to 0.2	10 mA to 10 A			
							10 A to 90 A			
						0.05 to 0.1	10 mA to 10 A			
							10 A to 90 A			
	AC power / Calibrators, transducers, 45 Hz to 65 Hz, 6 V to 720 V, 0.15 A to 21 A	0.9 W to 15 kW				cos φ		Direct measurement with a standard wattmeter	SEC-KM-P	
						1	0.046 %			
						0.9 to 1	0.060 %			
						0.8 to 0.9	0.065 %			
						0.7 to 0.8	0.070 %			
						0.6 to 0.7	0.080 %			
						0.5 to 0.6	0.090 %			
						0.4 to 0.5	0.11 %			
						0.3 to 0.4	0.14 %			
						0.2 to 0.3	0.20 %			
						0.1 to 0.2	0.39 %			
						0.05 to 0.1	0.80 %			
11	Power level / HF voltage meters, oscilloscopes and instruments for the measurement of frequency	-90 dBm to -80 dBm				10 kHz to 1 GHz	0.35 dB	Direct generation with a standard generator – 50 Ω load	SEC-KM-Uvf	
						1 GHz to 2.5 GHz	0.60 dB			
						5 GHz	1.2 dB			
						10 GHz	1.2 dB			
		-80 dBm to -60 dBm				10 kHz to 1 GHz	0.35 dB			
						1 GHz to 2.5 GHz	0.51 dB			
						5 GHz	1.2 dB			
						10 GHz	1.2 dB			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
						15 GHz	1.3 dB			
						20 GHz	1.3 dB			
		-60 dBm	to	0 dBm		10 kHz to 1 GHz	0.35 dB			
						1 GHz to 2.5 GHz	0.51 dB			
						5 GHz	1.2 dB			
						10 GHz	1.2 dB			
						15 GHz	1.3 dB			
						20 GHz	1.3 dB			
		0 dBm	to	10 dBm		10 kHz to 1 GHz	0.33 dB			
						1 GHz to 2.5 GHz	0.47 dB			
						5 GHz	1.2 dB			
						10 GHz	1.2 dB			
						15 GHz	1.3 dB			
						20 GHz	1.3 dB			
	Power level / Generators and instruments for the generation of frequency	-90 dBm	to	-80 dBm		100 kHz to 2.5 GHz	0.35 dB	Direct measurement with a standard analyzer – 50 Ω load	SEC-KM-Uvf	
						5 GHz	0.51 dB			
						10 GHz	0.71 dB			
						15 GHz	1.7 dB			
						20 GHz	1.7 dB			
						25 GHz	1.7 dB			
		-80 dBm	to	-60 dBm		100 kHz to 2.5 GHz	0.30 dB			
						5 GHz	0.51 dB			
						10 GHz	0.71 dB			
						15 GHz	1.7 dB			
						20 GHz	1.7 dB			
						25 GHz	1.7 dB			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		-60 dBm to 0 dBm				100 kHz to 2.5 GHz	0.30 dB	Direct measurement with a standard power sensor - 50 Ω load		
						2.5 GHz to 5 GHz	0.35 dB			
						5 GHz to 10 GHz	0.68 dB			
						10 GHz to 15 GHz	0.86 dB			
						15 GHz to 18 GHz	0.92 dB			
						20 GHz 25 GHz				
		1.7 dB								
		0 dBm to 13 dBm				100 kHz to 2.5 GHz	0.30 dB	Direct measurement with a standard power sensor - 50 Ω load		
						2.5 GHz to 5 GHz	0.35 dB			
						5 GHz to 10 GHz	0.68 dB			
						15 GHz to 18 GHz	0.92 dB			
		13 dBm to 20 dBm				100 kHz to 200 MHz	0.75 dB	Direct measurement with a standard analyzer - 50 Ω load		
						200 MHz to 1 GHz	0.55 dB			
						1 GHz to 2.5 GHz	0.63 dB			

¹ Asterisk at the ordinal number identifies the calibrations, which the Laboratory is qualified to carry out outside the permanent laboratory premises.

² The expanded measurement uncertainty is in accordance with ILAC-P14 and EA-4/02 M part of CMC, and it is the lowest value of the respective uncertainty. If not stated otherwise, its coverage probability is approx. 95 %. If not stated otherwise, the uncertainty values stated without a unit are relative to the value measured. The uncertainty value stated herein is based on the best conditions achievable by the laboratory; the uncertainty value of a specific calibration may be higher, depending on the conditions of such a calibration. For identical extreme values of adjacent ranges, the lower uncertainty value always applies.

³ If the document identifying the calibration procedure is dated, only these specific procedures are used. If the document identifying the calibration procedure is not dated, the latest edition of the specified procedure is used (including any changes).

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CMC for the field of measured quantity: Time and frequency quantities

Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
1	Frequency / Oscilloscopes and instruments for the measurement of frequency	0.01 Hz	to	0.1 Hz		U _{inp} 100 mV to 10 V rectangle	1.2·10 ⁻⁷ Hz	Direct measurement of a signal synchronized by a GPS standard	SEC-KM-f	
		0.1 Hz	to	1 Hz			1.2·10 ⁻⁷ Hz			
		1 Hz	to	10 Hz			1.2·10 ⁻⁷ Hz			
		10 Hz	to	100 Hz			1.2·10 ⁻⁶ Hz			
		10 Hz	to	100 Hz		30 mV to 5 V sine	1.0·10 ⁻³ Hz			
		100 Hz	to	1 kHz			1.0·10 ⁻⁴ Hz			
		1 kHz	to	10 kHz			1.5·10 ⁻⁵ Hz			
		10 kHz	to	100 kHz			1.2·10 ⁻⁴ Hz			
		100 kHz	to	1 MHz			1.2·10 ⁻³ Hz			
		1 MHz	to	10 MHz			1.2·10 ⁻² Hz			
		10 MHz	to	100 MHz			1.2·10 ⁻¹ Hz			
		100 MHz	to	1 GHz			1.2·10 ⁰ Hz			
		1 GHz	to	2 GHz			3.2·10 ⁰ Hz			
		2 GHz	to	2.5 GHz			4.0·10 ⁰ Hz			
		2.5 GHz	to	5 GHz			8.0·10 ⁰ Hz			
		5 GHz	to	10 GHz			1.6·10 ¹ Hz			
		10 GHz	to	15 GHz			2.4·10 ¹ Hz			
		15 GHz	to	20 GHz			3.2·10 ¹ Hz			
		20 GHz	to	25 GHz			4.2·10 ¹ Hz			
	Frequency / Instruments for the generation of frequency	10 kHz	to	100 kHz		U _{out} 30 mV to 1 V sine	1.2·10 ⁻⁴ Hz	Direct measurement by a counter synchronized by a GPS standard		
		100 kHz	to	1 MHz			1.2·10 ⁻³ Hz			
		1 MHz	to	10 MHz			1.2·10 ⁻² Hz			

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Ord. number ¹	Calibrated quantity / Subject of calibration	Nominal range				Parameter(s) of the measurand	Lowest stated expanded measurement uncertainty ²	Calibration principle	Calibration procedure identification ³	Loca- tion
		min.	unit	max.	unit					
		10 MHz	to	100 MHz			1.2·10 ⁻¹ Hz			
		100 MHz	to	1 GHz			1.2·10 ⁰ Hz			
		1 GHz	to	2 GHz			3.2·10 ⁰ Hz			
		2 GHz	to	2.5 GHz			4.0·10 ⁰ Hz			
		2.5 GHz	to	5 GHz			8.0·10 ⁰ Hz			
		5 GHz	to	10 GHz			1.6·10 ¹ Hz			
		10 GHz	to	15 GHz			2.4·10 ¹ Hz			
		15 GHz	to	20 GHz			3.2·10 ¹ Hz			
				0.1 Hz		1 V rectangle (pp)	2.2·10 ⁻⁴ Hz			
				1 Hz			2.2·10 ⁻⁴ Hz			
				10 Hz			2.2·10 ⁻⁴ Hz			
				100 Hz			2.2·10 ⁻⁴ Hz			
				1 kHz			2.2·10 ⁻⁴ Hz			
				10 kHz			2.2·10 ⁻⁴ Hz			
				100 kHz			2.2·10 ⁻⁴ Hz			
2	Bandwidth / Oscilloscopes and instruments for the measurement of frequency	0 MHz	to	250 MHz			12 %	Direct generation with a standard generator	SEC-KM-OSC	
		250 MHz	to	500 MHz			13 %			
3	Time stamps / Oscilloscopes and inspection instruments			5 s			5.0·10 ⁻³ s	Direct generation with a standard generator	SEC-KM-OSC	
				2 s			1.0·10 ⁻³ s		KP 4.1.3/02/16	
				1 s			0.1·10 ⁻³ s		I-010	
				0.5 s			0.5·10 ⁻⁴ s			
				0.2 s			0.2·10 ⁻⁴ s			
				0.1 s			0.1·10 ⁻⁴ s			
				50 ms			0.5·10 ⁻⁵ s			

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		min.	unit	max.	unit					
				20 ms			$0.8 \cdot 10^{-6} \text{ s}$			
				10 ms			$0.2 \cdot 10^{-6} \text{ s}$			
				5 ms			$0.3 \cdot 10^{-7} \text{ s}$		SEC-KM-OSC	
				2 ms			$0.3 \cdot 10^{-7} \text{ s}$			
				1 ms			$0.3 \cdot 10^{-7} \text{ s}$			
				500 µs			$0.1 \cdot 10^{-8} \text{ s}$			
				200 µs			$0.1 \cdot 10^{-8} \text{ s}$			
				100 µs			$0.1 \cdot 10^{-8} \text{ s}$			
				50 µs			$0.1 \cdot 10^{-9} \text{ s}$			
				20 µs			$0.1 \cdot 10^{-9} \text{ s}$			
				10 µs			$0.1 \cdot 10^{-9} \text{ s}$			
				5 µs			$0.1 \cdot 10^{-10} \text{ s}$			
				2 µs			$0.1 \cdot 10^{-10} \text{ s}$			
				1 µs			$0.1 \cdot 10^{-10} \text{ s}$			
				500 ns			$0.1 \cdot 10^{-11} \text{ s}$			
				200 ns			$0.1 \cdot 10^{-11} \text{ s}$			
				100 ns			$0.1 \cdot 10^{-11} \text{ s}$			
				50 ns			$0.1 \cdot 10^{-12} \text{ s}$			
				20 ns			$0.1 \cdot 10^{-12} \text{ s}$			
				10 ns			$0.1 \cdot 10^{-12} \text{ s}$			
				5 ns			$0.1 \cdot 10^{-13} \text{ s}$			
				2 ns			$0.1 \cdot 10^{-13} \text{ s}$			
				1 ns			$0.1 \cdot 10^{-13} \text{ s}$			

¹ Asterisk at the ordinal number identifies the calibrations, which the Laboratory is qualified to carry out outside the permanent laboratory premises.

² The expanded measurement uncertainty is in accordance with ILAC-P14 and EA-4/02 M part of CMC, and it is the lowest value of the respective uncertainty. If not stated otherwise, its coverage probability is approx. 95 %. If not stated otherwise, the uncertainty values stated without a unit are relative to the value measured. The uncertainty value stated herein is based on the best conditions achievable by the laboratory; the uncertainty value of a specific calibration may be higher, depending on the conditions of such a calibration. For identical extreme values of adjacent ranges, the lower uncertainty value always applies.

³ If the document identifying the calibration procedure is dated, only these specific procedures are used. If the document identifying the calibration procedure is not dated, the latest edition of the specified procedure is used (including any changes).

Accredited entity according to ČSN EN ISO/IEC 17025:2018:

SEC electronic s.r.o.
CAB number 2356, Calibration Laboratory
Arnošta z Pardubic 2762, 530 02 Pardubice

"This document is an appendix to the certificate of accreditation. In case of any discrepancies between the English and Czech versions, the Czech version shall prevail, both for the certificate appendix and the certificate itself. "